

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/422,565	YOSHIDA, MEGUMI	
Examiner	Art Unit	_
Mylinh Tran	2179	

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Text search	1/2/06	ZUL	
NPL, EAST, USPAT, VSPGPUB	8/25/06	rul	
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